SPECIFICATION

SPEC. No. A-SoftC-a D A T E : 2013 Sep.

То

Non-Controlled Copy

CUSTOMER'S PF	RODUCT NAME	MULTI CGA S	TDK PRODUCT NAME MULTILAYER CERAMIC CHIP CAPACITORS CGA Series / Automotive Grade Soft Termination				
	specification to TDK ed without returned s side.	representatives.		judge that s	specificat	ion is	
RECEIPT	CONFIRMAT	ION					
		DATE:	YEAR	MONT	TH	DAY	
•		DATE: TDK-EPC Corpo Engineering		MONT	TH	DAY	
Sales Electronic Compor		TDK-EPC Corpo	ration		<u>TH</u>	DAY	
TDK Corporation Sales Electronic Compor Sales & Marketing APPROVED		TDK-EPC Corpo Engineering	ration	Group	TH Person in		

1. SCOPE

This specification is applicable to chip type multilayer ceramic capacitors with a priority over the other relevant specifications.

Production places defined in this specification shall be TDK-EPC Corporation Japan, TDK(Suzhou)Co.,Ltd and TDK Components U.S.A. Inc.

EXPLANATORY NOTE:

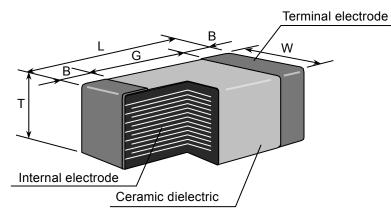
This specification warrants the quality of the ceramic chip capacitors. The chips should be evaluated or confirmed a state of mounted on your product.

If the use of the chips goes beyond the bounds of the specification, we can not afford to guarantee.

2. CODE CONSTRUCTION

(Example)	
-----------	--

Catalog Number : (Web)	<u>CGA4</u> (1)	<u>J</u> (2)	<u>3</u> (3)	<u>X7R</u> (4)	<u>1C</u> (5)	<u>475</u> (6)	<u>M</u> (7)	<u>125</u> (8)	<u>A</u> <u>E</u> (9) (10)
Item Description :	<u>CGA4</u> (1)	<u> J </u> (2)	<u>3</u> (3)	<u>X7R</u> (4)	<u>1C</u> (5)	<u>475</u> (6)	<u>M</u> (7)	<u> </u>	<u> </u>
(1) Type									

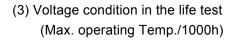


Please refer to product list for the dimension of each product.

(2) Thickness

Thickness	Dimension(mm)			
F	0.85			
Н	1.15			
J	1.25			
К	1.30 1.60 2.00			
L				
М				
Ν	2.30			
Р	2.50			

Sign	Condition			
1	Rated Voltage x 1			
2	Rated Voltage x 2			
3	Rated Voltage x 1.5			
4	Rated Voltage x 1.2			





- (4) Temperature Characteristics (Details are shown in table 1 No.6 at page 6)
- (5) Rated Voltage

Symbol	Rated Voltage		
2 J	DC 630 V		
2 W	DC 450 V		
2 E	DC 250 V		
2 A	DC 100 V DC 50 V		
1 H			
1 V	DC 35 V		
1 E	DC 25 V		
1 C	DC 16 V		

(6) Rated Capacitance

Stated in three digits and in units of pico farads (pF). The first and Second digits identify the first and second significant figures of the capacitance, the third digit identifies the multiplier.

R is designated for a decimal point.

Example 475 \rightarrow 4,700,000pF (4.7uF)

(7) Capacitance tolerance

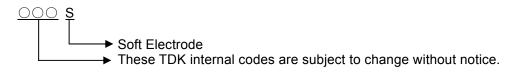
* M tolerance shall be TDK standard for over 10uF.

Symbol	Tolerance
К	± 10 %
М	± 20 %

- (8) Thickness code (Only Catalog Number)
- (9) Package code (Only Catalog Number)
- (10) Special code (Only Catalog Number)
- (11) Packaging

Symbol	Packaging
В	Bulk
Т	Taping

(12) TDK Internal code





3. RATED CAPACITANCE AND CAPACITANCE TOLERANCE

Temperature Characteristics	Capacitance tolerance	Rated capacitance
X7R X7S X7T	K (± 10 %) M (± 20 %)	E – 3 series

3.1 Standard combination of rated capacitance and tolerances

* The standard capacitance tolerance is M (± 20 %).

3.2 Capacitance Step in E series

E series	Capacitance Step			
 E- 3	1.0	2.2	4.7	

4. OPERATING TEMPERATURE RANGE

T.C.	Min. operating	Max. operating	Reference	
	Temperature	Temperature	Temperature	
X7R X7S X7T	-55°C	125°C	25°C	

5. STORING CONDITION AND TERM

5 to 40°C at 20 to 70%RH 6 months Max.

6. P.C. BOARD

When mounting on an aluminum substrate, large case sizes such as CGA6, CGA8 and CGA9 types are more likely to be affected by heat stress from the substrate. Please inquire separate specification for the large case sizes when mounted on the substrate.

7. INDUSTRIAL WASTE DISPOSAL

Dispose this product as industrial waste in accordance with the Industrial Waste Law.





8. PERFORMANCE

table 1

No.	Item	Per	formance	Test or inspection method			
1	External Appearance	No defects white performance.	Inspect with magnifying glass (3×).				
2	Insulation Resistance	10,000MΩ or 5 (As for the capa voltage 16V DC 100MΩ·μF min whichever sma	Apply rated voltage for 60s. As for the rated voltage 630V DC, ap 500V DC.				
3	Voltage Proof	Withstand test insulation brea damage.	Rated voltageApply voltage100V and under2.5 × rated voltageOver 100V1.5 × rated voltageAbove DC voltage shall be applied for1 to 5s.Charge / discharge current shall notexceed 50mA.				
4	Capacitance	Within the specified tolerance.		Capac 10uF	ted sitance and der	Measuring frequency 1kHz±10%	Measuring voltage 1.0±0.2Vrms.
5	Dissipation Factor	T.C. X7R X7S X7T	conditio For info	n. rmatior ion Fac		-	
6	Temperature Characteristics of Capacitance	Capacitar No vo X7 X7 X7	$ \begin{array}{c c} & \text{Capacitance shall be measured by the steps shown in the following table after thermal equilibrium is obtained for each step. \\ & \Delta C \text{ be calculated ref. STEP3 reading} \\ \hline & \Delta C \text{ be calculated ref. STEP3 reading} \\ \hline & \overline{Step} & \overline{Temperature(^{\circ}C)} \\ \hline & 1 & \text{Reference temp. } \pm 2 \\ \hline & 2 & \text{Min. operating temp. } \pm 2 \\ \hline & 3 & \text{Reference temp. } \pm 2 \\ \hline & 4 & \text{Max. operating temp. } \pm 2 \\ \hline \end{array} $			table after ed for each 3 reading $e(^{\circ}C)$ mp. ± 2 emp. ± 2 mp. ± 2	



No.	Item	Performance	Test or inspection method
7	Robustness of	No sign of termination coming	Reflow solder the capacitors on a
	Terminations	off, breakage of ceramic, or	P.C.Board shown in Appendix 1a or
		other abnormal signs.	Appendix 1b and apply a pushing force
			of 17.7N with 10±1s.
			Pushing force P.C.Board
8	Bending	No mechanical damage.	Reflow solder the capacitors on
			a P.C.Board shown in Appendix 2 and
			bend it for 5mm. (2mm is applied for
			CGA8 and CGA9.)
			50 F R230 (Unit : mr
9	Soldorability	New solder to cover over 75% of	Completely soak both terminations in
ฮ	Solderability	termination.	solder at 235±5°C for 2±0.5s.
		25% may have pin holes or	
		rough spots but not	Solder : H63A (JIS Z 3282)
		concentrated in one spot.	
		Ceramic surface of A sections	Flux: Isopropyl alcohol (JIS K 8839)
		shall not be exposed due to	Rosin (JIS K 5902) 25% solid
		melting or shifting of termination	solution.
		material.	
		A section	



No.	Ite	em	Perfo	ormance	Test or inspection method	
10	ResistanceExternalto solderappearanceheat		No cracks are a terminations she least 60% with	all be covered at	Completely soak both terminations in solder at 260±5°C for 5±1s.	
		Capacitance	Characteristics X7R	Change from the value before test	Preheating condition Temp. : 150±10°C Time : 1 to 2min.	
			X7S X7T	± 7.5 %	Flux : Isopropyl alcohol (JIS K 8839) Rosin (JIS K 5902) 25% solid solution.	
		D.F.	Meet the initial	spec.	Solder : H63A (JIS Z 3282)	
	Insulation Resistance		Meet the initial	spec.	Leave the capacitors in ambient – condition for 24±2h before measurement.	
		Voltage proof	No insulation breakdown or other damage.			
11	Vibration	External appearance	No mechanical	damage.	Reflow solder the capacitors on a P.C.Board shown in Appendix 1a or	
		Capacitance	Characteristics X7R X7S X7T	Change from the value before test ± 7.5 %	 Appendix 1b before testing. Vibrate the capacitor with following conditions. Applied force : 5G max. Frequency : 10-2000Hz 	
		D.F.	Meet the initial	spec.	 Duration : 20 min. Cycle : 12 cycles in each 3 mutually perpendicular directions. 	

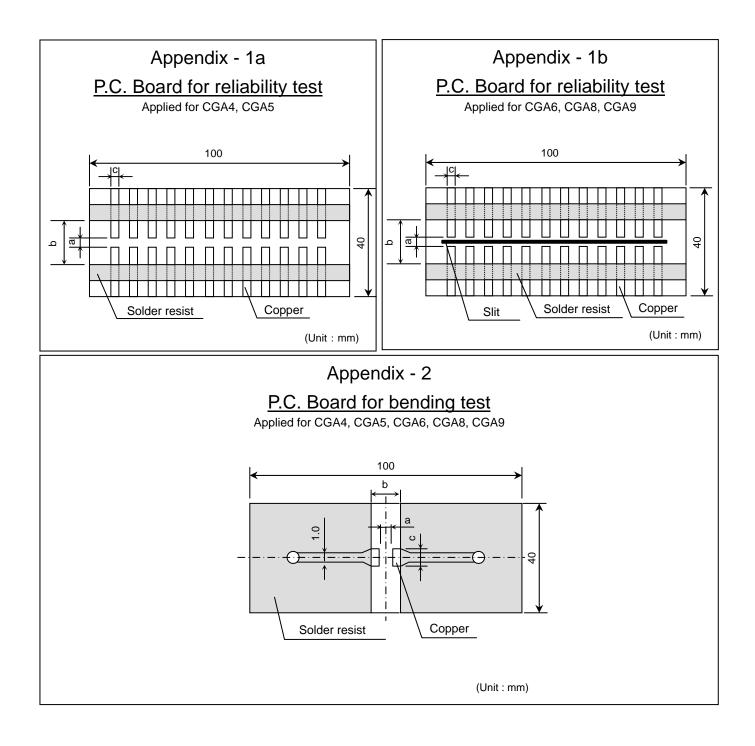


No.	lte	em	Performance		Test or inspection method			
12	Temperature cycle	External appearance	No mechanical damage.		Reflow solder the capacitors on a P.C.Board shown in Appendix 1a or			
		Capacitance			Appendix 1b before testing.			
			Characteristics	Change from the value before test		e the capacitors in the		
			X7R X7S X7T	± 7.5 % ± 12.5 %		hrough step 4 and re consecutively.	peat 1,000	
		D.F.	Most the initial			the capacitors in amb on for 24±2h before n		
		D.F.	Meet the initial	spec.			[
		Insulation	Meet the initial	spec.	Step	Temperature(°C)	Time (min.)	
		Resistance Voltage	No insulation b	reakdown or other	1 Min. operating temp. ±3		30 ± 3	
		proof	damage.		2	Reference Temp.	2 - 5	
					3	Max. operating temp. ±2	30 ± 2	
					4	Reference Temp.	2 - 5	
13	Moisture	External	No mechanical damage.		Reflow solder the capacitors on a			
	Resistance	appearance			P.C.Board shown in Appendix 1a or			
		Steady Capacitance State)	Characteristics	Change from the	Append	dix 1b before testing.		
	,		Characteristics	value before test	Leave	Leave at temperature 40±2°C, 90		
			X7R X7S X7T	± 12.5 % ± 25 %	95%RH for 500 +24,0h.			
					Leave the capacitors in ambient			
		D.F.	Characteristics 200% of initial spec. max		conditio	on for 24±2h before n	neasurement	
		Insulation	1,000MΩ or 50M	lΩ·µF min.	_			
		Resistance	(As for the cap	acitors of rated				
			voltage 16V DC					
			10MΩ·µF min., whichever sma					
			whichever sma					



l o.			Performance		Test or inspection method Reflow solder the capacitors on a		
14 Moist Resis		External appearance	No mechanical	damage.	Reflow solder the capacitors on a P.C.Board shown in Appendix 1a or Appendix 1b before testing.		
		Capacitance					
			Characteristics	Change from the value before test	Apply the rated voltage at temperature 85°C and 85%RH for 1,000 +48,0h.		
			X7R X7S X7T	± 12.5 % ± 25 %	Charge/discharge current shall not exceed 50mA.		
		D.F.	Characteristics 200% of initial	spec. max	Leave the capacitors in ambient condition for 6 to 24h (Class1) or 24±2h (Class2) before measurement. Voltage conditioning (only for class2) Voltage treat the capacitor under		
		Insulation Resistance	500MΩ or 25MΩ· μ F min. (As for the capacitors of rated voltage 16V DC, 500 MΩ or 5MΩ· μ F min.,) whichever smaller.		testing temperature capacitor under testing temperature and voltage for 1hour. Leave the capacitors in ambient condition for 24±2h before measurement. Use this measurement for initial value.		
5 Life		External appearance	No mechanical damage.		Reflow solder the capacitors on a P.C.Board shown in Appendix 1a or Appendix 1b before testing.		
		Capacitance	Characteristics	Change from the value before test	Below the voltage shall be applied at 125±2°C for 1,000 +48, 0h.		
			X7R	+ 15 %	Applied voltage		
			X7S X7T	± 25 %	Rated voltage x2		
					Rated voltage x1.5		
		D.F.	Characteristics		Rated voltage x1.2		
	Insulation Resistance	200% of initial spec. max		Rated voltage x1			
				1,000MΩ or 50M (As for the capa	•	 For information which product has which applied voltage, please contact with our sales representative. 	
			voltage 16V DC, 1,000 MΩ or 10MΩ·μF min.,)		Charge/discharge current shall not exceed 50mA.		
			whichever sma	ller.	Leave the capacitors in ambient condition for 6 to 24h (Class1) or 24±2h (Class2) before measurement.		
					Voltage conditioning (only for class2) Voltage treat the capacitor under testing temperature and voltage for 1hour.		
					Leave the capacitors in ambient condition for 24±2h before measurement. Use this measurement for initial		

*As for the initial measurement of capacitors on number 6,10,11,12 and 13, leave capacitors at 150 –10,0°C for 1 hour and measure the value after leaving capacitors for 24±2h in ambient condition.



P.C. Board thickness : Appendix-1a, 1b, 2 1.6mm

	Dimensions (mm)				
I DK (EIA Style)	а	b	С		
CGA4 (CC0805)	1.2	4.0	1.65		
CGA5 (CC1206)	2.2	5.0	2.0		
CGA6 (CC1210)	2.2	5.0	2.9		
CGA8 (CC1812)	3.5	7.0	3.7		
CGA9 (CC2220)	4.5	8.0	5.6		
	CGA5 (CC1206) CGA6 (CC1210) CGA8 (CC1812)	TDK (EIA style) a CGA4 (CC0805) 1.2 CGA5 (CC1206) 2.2 CGA6 (CC1210) 2.2 CGA8 (CC1812) 3.5	TDK (EIA style) a b CGA4 (CC0805) 1.2 4.0 CGA5 (CC1206) 2.2 5.0 CGA6 (CC1210) 2.2 5.0 CGA8 (CC1812) 3.5 7.0		

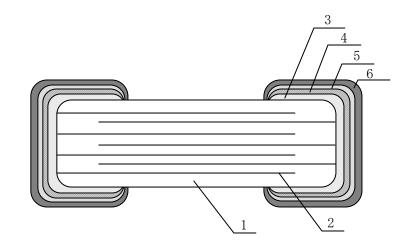


Copper (thickness 0.035mm)

Solder resist



9. INSIDE STRUCTURE AND MATERIAL



No.	NAME	MATERIAL
1	Dielectric	BaTiO ₃
2	Electrode	Nickel (Ni)
3		Copper (Cu)
4	Termination	Conductive resin (Filler : Ag)
5	remination	Nickel (Ni)
6		Tin (Sn)

10. RECOMMENDATION

As for CGA6, CGA8 and CGA9 types, It is recommended to provide a slit (about 1mm wide) in the board under the components to improve washing Flux. And please make sure to dry detergent up completely before.

11. SOLDERING CONDITION

As for CGA6, CGA8 and CGA9 types, reflow soldering only.



12. Caution

141	Oddilon						
No.	Process	Condition					
1	Operating Condition (Storage,	 1-1. Storage 1) The capacitors must be stored in an ambient temperature of 5 to 40°C with a relative humidity of 20 to 70%RH. The products should be used within 6 months upon receipt. 					
	Transportation)	 The capacitors must be operated and stored in an environment free of dew condensation and these gases such as Hydrogen Sulphide, Hydrogen Sulphate, Chlorine, Ammonia and sulfur. 					
		3) Avoid storing in sun light and falling of dew.					
		4) Do not use capacitors under high humidity and high and low atmospheric pressure which may affect capacitors reliability.					
		5) Capacitors should be tested for the solderability when they are stored for long time.					
		1-2. Handling in transportation					
		In case of the transportation of the capacitors, the performance of the capacitors may be deteriorated depending on the transportation condition. (Refer to JEITA RCR-2335B 9.2 Handling in transportation)					
2	Circuit design	 2-1. Operating temperature Operating temperature should be followed strictly within this specification, especially be careful with maximum temperature. 1) Do not use capacitors above the maximum allowable operating temperature. 					
		2) Surface temperature including self heating should be below maximum operating temperature.					
		(Due to dielectric loss, capacitors will heat itself when AC is applied. Especially at					
		high frequencies around its SRF, the heat might be so extreme that it may damage					
		itself or the product mounted on. Please design the circuit so that the maximum temperature of the capacitors including the self heating to be below the maximum					
		allowable operating temperature. Temperature rise at capacitor surface shall be					
		below 20°C)					
		3) The electrical characteristics of the capacitors will vary depending on the					
		temperature. The capacitors should be selected and designed in taking the temperature into consideration.					
		2-2. Operating voltage					
		 Operating voltage across the terminals should be below the rated voltage. When AC and DC are super imposed, V_{0-P} must be below the rated voltage. (1) and (2) 					
		AC or pulse with overshooting, V_{P-P} must be below the rated voltage. (1) and (2) (2) (3), (4) and (5)					
		When the voltage is started to apply to the circuit or it is stopped applying, the irregular voltage may be generated for a transit period because of resonance or switching. Be sure to use the capacitors within rated voltage containing these Irregular voltage.					
		Voltage (1) DC voltage (2) DC+AC voltage (3) AC voltage					
		Positional V_{0-P} Measurement V_{0-P}					
		(Rated voltage)					
		(4) Dules voltage (A) (5) Dules voltage (B)					
		Voltage (4) Pulse voltage (A) (5) Pulse voltage (B)					
	1						



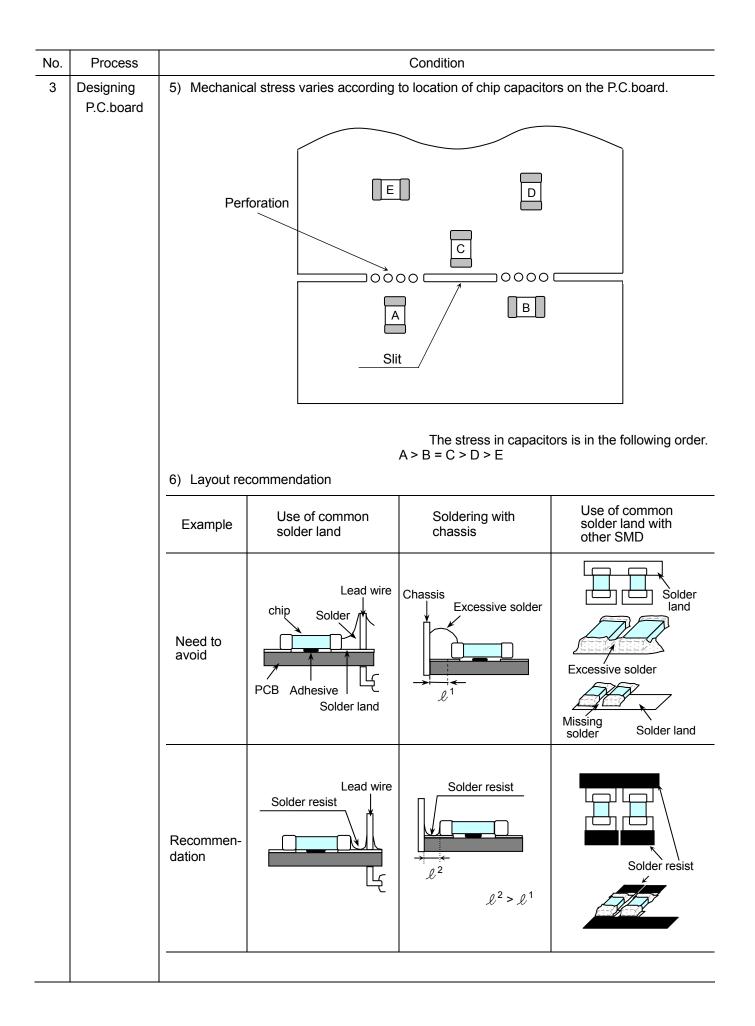


No.	Process			Condition			
2	Circuit design <u>∧</u> Caution	2) Even below the rated voltage, if repetitive high frequency AC or pulse is applied, the reliability of the capacitors may be reduced.					
		3) The effective The capacitor consideration	s should be sele		g on applied DC a ned in taking the		
					C and/or pulse v erate audible sou		
3	Designing P.C.board		ne amount of sol likely that it will	der, the higher t break. When de	the stress on the	chip capacitors, ard, determine the	
			ommon solder la r each terminatio		terminations and	provide individual	
		3) Size and reco	mmended land	dimensions.			
			(Chip capacitors	Solder land		
						Solder resist	
		Flow solder		ך ו)	mm)		
		Type Symbol	-	CGA5 (CC1206	<u> </u>		
		A	1.0 - 1.3	2.1 - 2.5	5		
		В	1.0 - 1.2	1.1 - 1.3	3		
		C	0.8 - 1.1	1.0 - 1.3	3		
		Reflow sold	ering	(mm)			
		Type Symbol	CGA4 (CC0805)	CGA5 (CC1206)			
		A	0.9 - 1.2	2.0 - 2.4			
		<u> </u>	0.7 - 0.9	1.0 - 1.2			
		C	0.9 - 1.2	1.1 - 1.6			
		Type Symbol	CGA6 (CC1210)	CGA8 (CC1812)	CGA9 (CC2220)		
		A	2.0 - 2.4	3.1 - 3.7	4.1 - 4.8		
		В	1.0 - 1.2	1.2 - 1.4	1.2 - 1.4		
		С	1.9 - 2.5	2.4 - 3.2	4.0 - 5.0		

⊘TDK

No.	Process	Process Condition						
3	Designing P.C.board							
			Disadvantage against bending stress	Advantage against bending stress				
		Mounting face	Perforation or slit	Perforation or slit				
			Break P.C.board with mounted side up.	Break P.C.board with mounted side down.				
		Chip arrangement (Direction)	Mount perpendicularly to perforation or slit	Mount in parallel with perforation or slit				
		Distance from slit	Closer to slit is higher stress $label{eq:loser}$ $label{eq:loser}$ $(\ell_1 < \ell_2)$	Away from slit is less stress l_2 $(l_1 < l_2)$				





No.	Process	Condition						
4	Mounting	 4-1. Stress from mounting head If the mounting head is adjusted too low, it may induce excessive stress in the chip capacitors to result in cracking. Please take following precautions. 1) Adjust the bottom dead center of the mounting head to reach on the P.C.board surface and not press it. 2) Adjust the mounting head pressure to be 1 to 3N of static weight. 3) To minimize the impact energy from mounting head, it is important to provide support from the bottom side of the P.C.board. See following examples. 						
		Not recommended Recommended						
		Single sided mounting						
		Double-sides mounting Solder peeling Crack						
		When the centering jaw is worn out, it may give mechanical impact on the ca to cause crack. Please control the close up dimension of the centering jaw ar provide sufficient preventive maintenance and replacement of it.						
		4-2. Amount of adhesive						
		Example : CGA4 (CC0805), CGA5 (CC1206)						
		a 0.2mm min.						
		<u>b</u> 70 - 100μm						
		C Do not touch the solder land						



No.	Process		C	ondition			
5	Soldering	5-1. Flux selection Although highly-activated flux gives better solderability, substances which increase activity may also degrade the insulation of the chip capacitors. To avoid such degradation, it is recommended following.					
		1) It is recommended to Strong flux is not reco	o use a mildly ad ommended.	ctivated rosin f	lux (less than 0	.1wt% chlorine	
		2) Excessive flux must b	be avoided. Plea	se provide pro	per amount of fl	ux.	
		3) When water-soluble f	lux is used, eno	ugh washing is	necessary.		
		5-2. Recommended sold	ering profile by v	various method	s		
		Wave sold	-		Reflow solde	-	
		Solde Preheating	Natural cooling	→	Preheating	ldering Natural cooling ≺→	
		Peak		Peak			
		Temp (C) C C C C C C C C C C C C C	Over 60 sec.	Temp (C) dub (°C)	r 60 sec.		
		Peak Temp time ← → ← → ← → ← → ← →					
		Manual soldering (Solder iron) <u>APPLICATION</u>					
		300 () () () () () () () () () ()	3sec. (As short a	applie solder As for CGA9 solder	CGA6 (CC1210), C (CC2220), applied	and reflow CGA8 (CC1812),	
		5-3. Recommended sold	ering peak temp	and peak tem	p duration		
		Temp./Duration	Wave so	oldering	Reflow set	oldering	
		Solder	Peak temp(°C)	Duration(sec.)	Peak temp(°C)	Duration(sec.)	
		Sn-Pb Solder	250 max.	3 max.	230 max.	20 max.	
		Lead Free Solder	260 max.	5 max.	260 max.	10 max.	
		Recommended solde Sn-37Pb (Sn-Pb sol Sn-3.0Ag-0.5Cu (Le	lder)				



oldering	5 4 4			tion		
	5-4. Avoiding thermal shock					
	1) Prel	heating condition				
		Soldering	-	Туре	Temp. (°C)	
		Wave soldering	CGA4(CC0805), C	GA5(CC1206)	∆T ≤ 150	
			CGA4(CC0805), C	GA5(CC1206)	∆T ≤ 150	
		Reflow soldering	CGA6(CC1210), C CGA9(CC2220)	GA8(CC1812),	∆T ≤ 130	
			CGA4(CC0805), C	GA5(CC1206)	∆T ≤ 150	
		Manual soldering	CGA6(CC1210), C CGA9(CC2220)	CGA8(CC1812),	∆T ≤ 130	
	5-5. Am E	emperature change	will induce higher	r tensile force ir It in chip cracking	n 100°C. n chip capacitors wh j. In sufficient solder n	
		letach the capacito	ors from the P.C.DO	aru.		
		cessive			her tensile force in o capacitors to cause ck	
	Ad	equate		Maximum Minimum		
		ufficient der		cau chip	v robustness may se contact failure or o capacitors come off P.C.board.	
	1) Sele Tip lan hea Ple tim chi	ection of the solderi o temperature of so id size. The higher at shock may cause ease make sure the ie in accordance wi p capacitors with th	ing iron tip Ider iron varies by the tip temperature e a crack in the chi e tip temp. before s ith following recom ne condition in 5-4	e, the quicker the p capacitors. oldering and keep mended condition to avoid the therm	operation. However, o the peak temp and n. (Please preheat the nal shock.)	
		200 may	3 may	20 max.	Ø 3.0 max.	
		1) Sele Tip Ian hea Ple tim chi	 Selection of the solder Tip temperature of so land size. The higher heat shock may caus Please make sure the time in accordance w chip capacitors with th Recommended sold Temp. (°C) 	land size. The higher the tip temperature heat shock may cause a crack in the chi Please make sure the tip temp. before s time in accordance with following recom chip capacitors with the condition in 5-4 Recommended solder iron condition (S	 Selection of the soldering iron tip Tip temperature of solder iron varies by its type, P.C.board land size. The higher the tip temperature, the quicker the heat shock may cause a crack in the chip capacitors. Please make sure the tip temp. before soldering and keep time in accordance with following recommended condition chip capacitors with the condition in 5-4 to avoid the therm Recommended solder iron condition (Sn-Pb Solder and Temp. (°C) Duration (sec.) Wattage (W) 	





No.	Process	Condition
5	Soldering	 Direct contact of the soldering iron with ceramic dielectric of chip capacitors may cause crack. Do not touch the ceramic dielectric and the terminations by solder iron.
		5-7. Sn-Zn solder
		Sn-Zn solder affects product reliability.
		Please contact TDK in advance when utilize Sn-Zn solder.
		 5-8. Countermeasure for tombstone The misalignment between the mounted positions of the capacitors and the land patterns should be minimized. The tombstone phenomenon may occur especially the capacitors are mounted (in longitudinal direction) in the same direction of the reflow soldering. (Refer to JEITA RCR-2335B Annex 1 (Informative) Recommendations to prevent to the tombstone phenomenon phenomenon)
		tombstone phenomenon)
6	Cleaning	 If an unsuitable cleaning fluid is used, flux residue or some foreign articles may stick to chip capacitors surface to deteriorate especially the insulation resistance.
		2) If cleaning condition is not suitable, it may damage the chip capacitors.
		2)-1. Insufficient washing
		(1) Terminal electrodes may corrode by Halogen in the flux.
		(2) Halogen in the flux may adhere on the surface of capacitors, and lower the insulation resistance.
		(3) Water soluble flux has higher tendency to have above mentioned problems (1) and (2).
		2)-2. Excessive washing
		When ultrasonic cleaning is used, excessively high ultrasonic energy output
		can affect the connection between the ceramic chip capacitor's body and the
		terminal electrode. To avoid this, following is the recommended condition.
		Power : 20 W/ ℓ max.
		Frequency : 40 kHz max.
		Washing time : 5 minutes max.
		2)-3. If the cleaning fluid is contaminated, density of Halogen increases, and it may bring the same result as insufficient cleaning.



No.	Process		Condition							
7	Coating and	1) When the	P.C.board is coated, please verify t	he quality influence on the product.						
	molding of the P.C.board		erify carefully that there is no harmfu during curing which may damage th							
		3) Please verify the curing temperature.								
8	Handling after chip mounted	 Please pay attention not to bend or distort the P.C.board after soldering in hand otherwise the chip capacitors may crack. 								
	▲ Caution		Bend	Twist						
		 2) When functional check of the P.C.board is performed, check pin pressure tends to be adjusted higher for fear of loose contact. But if the pressure is excessive and bend the P.C.board, it may crack the chip capacitors or peel the terminations off. Please adjust the check pins not to bend the P.C.board. 								
		Item	Recommended							
		Board bending	Not recommended	Support pin						
9	Handling of loose chip capacitors	the large (handle wi 2) Piling the	case sized chip capacitors are tende	_						





No.	Process	Condition
10	Capacitance aging	The capacitors (Class 2) have aging in the capacitance. They may not be used in precision time constant circuit. In case of the time constant circuit, the evaluation should be done well.
11	Estimated life and estimated failure rate of capacitors	As per the estimated life and the estimated failure rate depend on the temperature and the voltage. This can be calculated by the equation described in JEITA RCR-2335B Annex 6 (Informative) Calculation of the estimated lifetime and the estimated failure rate (Voltage acceleration coefficient : 3 multiplication rule, Temperature acceleration coefficient : 10°C rule) The failure rate can be decreased by reducing the temperature and the voltage but they will not be guaranteed.
12	Others	The products listed on this specification sheet are intended for use in general electronic equipment (AV equipment, telecommunications equipment, home appliances, amusement equipment, computer equipment, personal equipment, office equipment, measurement equipment, industrial robots) under a normal operation and use condition. The products are not designed or warranted to meet the requirements of the applications listed below, whose performance and/or quality require a more stringent level of safety or reliability, or whose failure, malfunction or trouble could cause serious damage to society, person or property. Please understand that we are not responsible for any damage or liability caused by use of the products in any of the applications below or for any other use exceeding the range or conditions set forth in this specification sheet. If you intend to use the products in the applications listed below or if you have special requirements exceeding the range or conditions set forth in this specification, please contact us. (1) Aerospace/Aviation equipment (2) Transportation equipment (3) Medical equipment (4) Power-generation control equipment (5) Atomic energy-related equipment (6) Seabed equipment (7) Transportation control equipment (8) Public information-processing equipment (9) Military equipment (10) Electric heating apparatus, burning equipment (11) Disaster prevention/crime prevention equipment (12) Safety equipment (13) Other applications that are not considered general-purpose applications When designing your equipment even for general-purpose applications, you are kindly requested to take into consideration securing protection circuit/device or providing backup circuits in your equipment.



13. Packaging label

Packaging shall be done to protect the components from the damage during transportation and storing, and a label which has the following information shall be attached.

1) Inspection No.
 2) TDK P/N
 3) Customer's P/N
 4) Quantity

*Composition of Inspection No.

Example $\underline{F} \underline{2} \underline{A} - \underline{OO} - \underline{OOO}$ (a) (b) (c) (d) (e)

a) Line code

b) Last digit of the year

c) Month and A for January and B for February and so on. (Skip I)

d) Inspection Date of the month.

e) Serial No. of the day

14. Bulk packaging quantity

Total number of components in a plastic bag for bulk packaging : 1,000pcs.



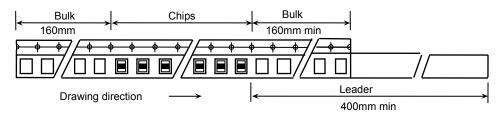
15. TAPE PACKAGING SPECIFICATION

1. CONSTRUCTION AND DIMENSION OF TAPING

1-1. Dimensions of carrier tape

Dimensions of paper tape shall be according to Appendix 3. Dimensions of plastic tape shall be according to Appendix 4, 5.

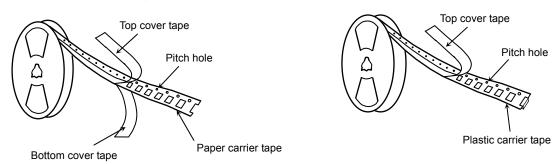
1-2. Bulk part and leader of taping



1-3. Dimensions of reel

Dimensions of Ø178 reel shall be according to Appendix 6, 7. Dimensions of Ø330 reel shall be according to Appendix 8, 9.

1-4. Structure of taping



2. CHIP QUANTITY

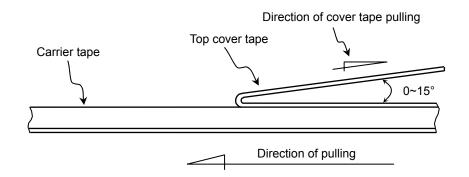
Туре	Thickness	Taping	Chip quantity(pcs.)		
туре	of chip	Material	φ178mm reel	φ330mm reel	
CGA4	0.85 mm	Paper	4,000	10,000	
(CC0805)	1.25 mm	Plastic	2,000	10,000	
COAF	1.15 mm			10,000	
CGA5 (CC1206)	1.30 mm	Plastic	2,000	10,000	
(001200)	1.60 mm			8,000	
	1.60 mm		2,000	8,000	
CGA6	2.00 mm	Plastic	1,000	5,000	
(CC1210)	2.30 mm	Flaslic			
	2.50 mm				
0049	2.00 mm		1,000		
CGA8 (CC1812)	2.30 mm	Plastic	500	3,000	
(001012)	2.50 mm		500		
CGA9	2.30 mm	Plastic	500	3 000	
(CC2220)	2.50 mm	Flaslic	500	3,000	



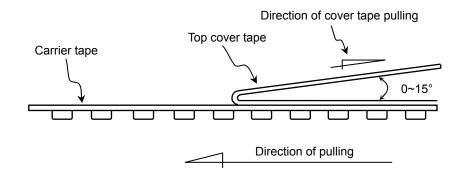
3. PERFORMANCE SPECIFICATIONS

- 3-1. Fixing peeling strength (top tape)
 - 0.05-0.7N. (See the following figure.)

TYPE 1 (Paper)



TYPE 2 (Plastic)

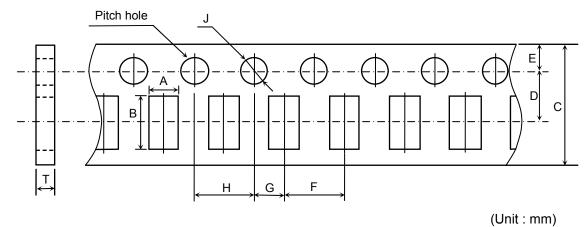


- 3-2. Carrier tape shall be flexible enough to be wound around a minimum radius of 30mm with components in tape.
- 3-3. The missing of components shall be less than 0.1%
- 3-4. Components shall not stick to fixing tape.
- 3-5. The fixing tapes shall not protrude beyond the edges of the carrier tape not shall cover the sprocket holes.



Appendix 3

Paper Tape



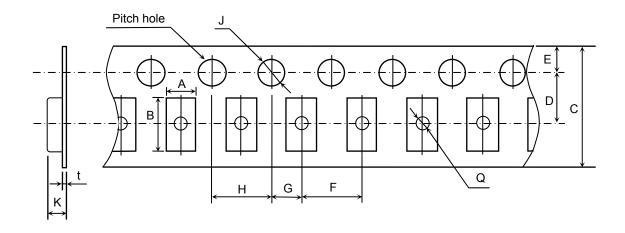
Symbol Type	А	В	С	D	E	F
CGA4 (CC0805)	(1.50)	(2.30)	8.00 ± 0.30	3.50 ± 0.05	1.75 ± 0.10	4.00 ± 0.10
Symbol Type	G	Н	J	Т		
CGA4 (CC0805)	2.00 ± 0.05	4.00 ± 0.10	Ø 1.5 +0.10 0	1.10 max.		

* The values in the parentheses () are for reference.



Appendix 4

Plastic Tape



(Unit : mm)

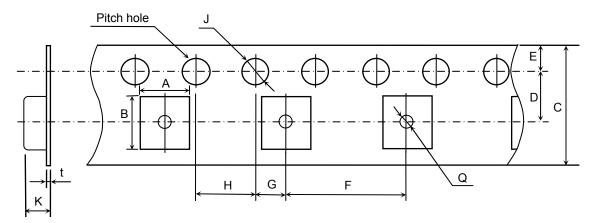
Symbol Type	А	В	С	D	Е	F
CGA4 (CC0805)	(1.50)	(2.30)	8.00 ± 0.30	3.50 ± 0.05		
CGA5 (CC1206)	(1.90)	(3.50)	0.00 ± 0.00	5.50 ± 0.05	1.75 ± 0.10	4.00 ± 0.10
CGA6 (CC1210)	(2.90)	(3.60)	8.00 ± 0.30 or 12.0 ± 0.30	3.50 ± 0.05 or 5.50 ± 0.05		
Symbol Type	G	Н	J	К	t	Q
CGA4 (CC0805)				2.50 max.		
CGA5 (CC1206)	2.00 ± 0.05	4.00 ± 0.10	Ø 1.5 +0.10 0	2.50 max.	0.60 max.	Ø 0.50 min.
CGA6 (CC1210)				3.20 max.		

* The values in the parentheses () are for reference.

* Exceptionally no hole in the cavity is applied. Please inquire if hole in cavity is mandatory.



Plastic Tape



(Unit : mm)

Symbol Type	A	В	С	D	E	F
CGA8 (CC1812)	(3.60)	(4.90)	12.0 ± 0.30	5.50 ± 0.05	1.75 ± 0.10	8.00 ± 0.10
CGA9 (CC2220)	(5.70)	(6.40)	12.0 ± 0.30	5.50 ± 0.05	1.75 ± 0.10	5.00 ± 0.10
Symbol Type	G	Н	J	К	t	Q
CGA8 (CC1812)	2.00 ± 0.05	4.00 ± 0.10	Ø 1.5 +0.10	6.50 max.	0.60 max.	Ø 1.50 min.
CGA9 (CC2220)	2.00 ± 0.05	4.00 ± 0.10	0	0.00 max.	0.00 max.	0 1.30 mm.

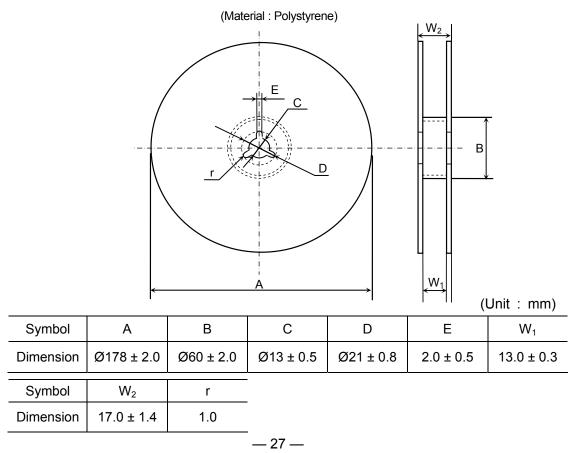
* The values in the parentheses () are for reference.



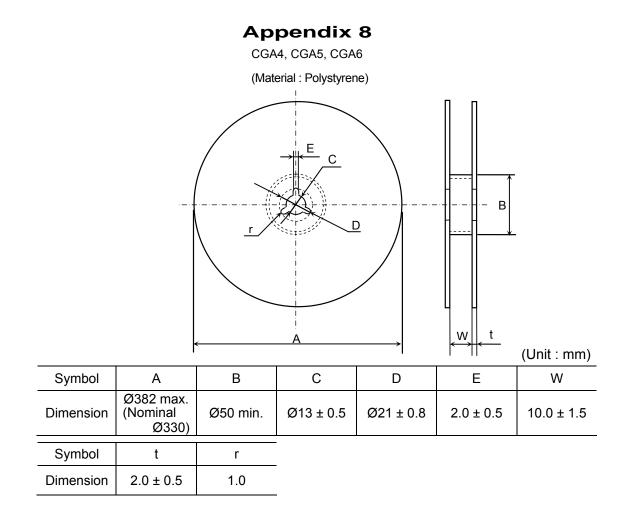
Appendix 6 CGA4, CGA5, CGA6								
	(Material : Polystyrene)							
Symbol	A	В	С	D	E	Unit : mm) W ₁		
Dimension	Ø178 ± 2.0	Ø60 ± 2.0	Ø13 ± 0.5	Ø21 ± 0.8	2.0 ± 0.5	9.0 ± 0.3		
Symbol	W ₂	r				·		
Dimension	13.0 ± 1.4	1.0						

Appendix 7

CGA6 12mm width taping type, CGA8, CGA9

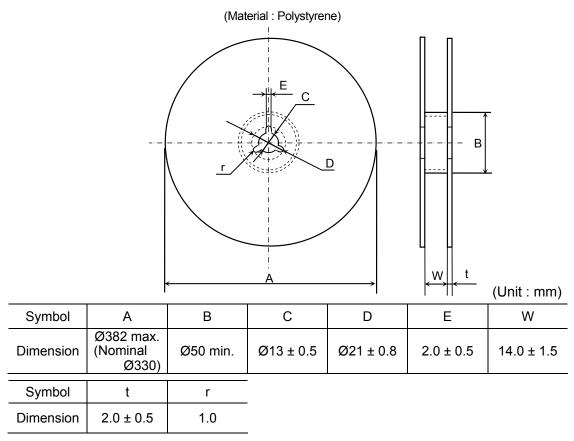






Appendix 9

CGA6 12mm width taping type, CGA8, CGA9





Mouser Electronics

Authorized Distributor

Click to View Pricing, Inventory, Delivery & Lifecycle Information:

TDK:

CGA4F4X7T2W103M/SOFT CGA4J3X7R2E103M/SOFT CGA4J3X7R2E223M/SOFT CGA4J3X7T2E104M/SOFT CGA4J3X7T2E473M/SOFT CGA4J4X7T2W223M/SOFT CGA4J4X7T2W473M/SOFT CGA5H4X7R2J103M/SOFT CGA5K4X7R2J223M/SOFT CGA5L1X7T2J473M/SOFT CGA5L3X7R2E104M/SOFT CGA5L3X7T2E224M/SOFT CGA5L4X7T2W104M/SOFT CGA6L1X7T2J104M/SOFT CGA6M3X7R2E104M/SOFT CGA6M3X7R2E224M/SOFT CGA6M4X7R2J473M/SOFT CGA6M4X7T2W224M/SOFT CGA8L1X7T2J154K CGA8L3C0G2E223J CGA8L3X7R2E154K CGA8L3X7T2E684K CGA8L4C0G2J103J CGA8L4C0G2J822J CGA8L4X7R2J683K CGA8L4X7T2W334K CGA8M1X7T2J224K CGA8M1X7T2J224M/SOFT CGA8M3C0G2E333J CGA8N3X7R2E224K CGA8N3X7R2E334K CGA8N3X7R2E474K CGA8N3X7R2E474M/SOFT CGA8N4X7R2J104K CGA8N4X7T2W474K CGA8N4X7T2W474M/SOFT CGA8P3X7T2E105K CGA8P3X7T2E105M/SOFT CGA8P4C0G2J153J CGA8R3C0G2E473J CGA8R4C0G2J223J CGA9L3X7R2E334K CGA9L4X7R2J154K CGA9M1X7T2J334K CGA9M3X7T2E155K CGA9M4X7T2W684K CGA9N3X7R2E105K CGA9N3X7R2E105M/SOFT CGA9N3X7R2E474K CGA9N3X7R2E684K CGA9N4X7R2J224K CGA9P1X7T2J474K CGA9P1X7T2J474M/SOFT CGA9P3X7T2E225K CGA9P3X7T2E225M/SOFT CGA9P4X7T2W105K CGA9P4X7T2W105M/SOFT CGA3E2C0G1H102J CGA3E2C0G1H122J CGA3E2C0G1H152J CGA3E2C0G1H182J CGA3E2C0G1H222J CGA3E2C0G1H272J CGA3E2C0G1H332J CGA3E2C0G2A102J CGA3E2C0G2A122J CGA3E3C0G2E101J CGA3E3C0G2E121J CGA3E3C0G2E151J CGA3E3C0G2E181J CGA3E3C0G2E221J CGA3E3C0G2E271J CGA3E3C0G2E331J CGA3E3C0G2E391J CGA3E3C0G2E471J CGA3E3C0G2E561J CGA3E3C0G2E681J CGA4C2C0G1H272J CGA4C2C0G1H332J CGA4C2C0G2A102J CGA4C2C0G2A122J CGA4C2C0G2A152J CGA4C3C0G2E821J CGA4F2C0G1H392J CGA4F2C0G1H472J CGA4F2C0G1H562J CGA4F2C0G2A182J CGA4F2C0G2A222J CGA4F3C0G2E102J CGA4F3C0G2E122J CGA4F3C0G2E152J CGA4F3X7R2E102K CGA4F3X7R2E152K CGA4F3X7R2E222K CGA4F3X7R2E332K CGA4F3X7R2E472K CGA4J2C0G1H682J CGA4J2C0G1H822J CGA4J2C0G2A272J CGA4J2C0G2A332J